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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Tyler A. Lowrey Et Al.

§ Group Art Unit: 2827

Serial No.: 10/633,872

§

Filed: August 4, 2003

§ Examiner: T. Le

For: Read Bias Scheme For Phase
Change Memories

§ Atty. Dkt. No.: ITO.0046US
(P16201)

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

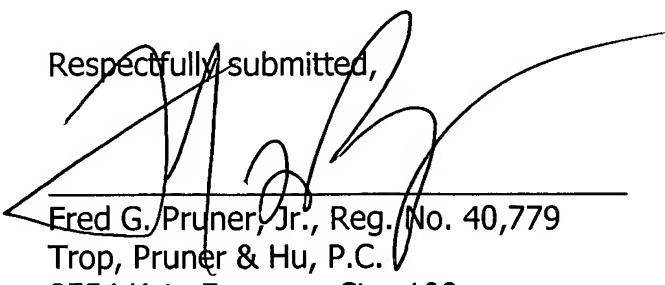
INFORMATION DISCLOSURE STATEMENT

Dear Sir:

Applicant submits the references listed on the attached form PTO 1449, copies of which are enclosed. A copy of a communication dated April 15, 2005 from a foreign patent office in a counterpart application is also enclosed. I, the undersigned, hereby certify that each item of information contained in the Information Disclosure Statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the Information Disclosure Statement. Please apply any charges or credits to Deposit Account No. 20-1504 (ITO.0046US).

May 12, 2005

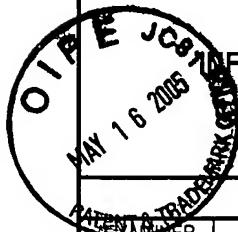
Date

Respectfully submitted,

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I hereby certify under 37 CFR 1.8(a) that this correspondence is being deposited with the United States Postal Service as **first class mail** with sufficient postage on the date indicated above and is addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

Monica Jacobs



INFORMATION DISCLOSURE CITATION
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APPLICANT(S):
Tyler A. Lowrey et al.
FILING DATE:
August 4, 2003 | GROUP ART UNIT:
2827

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
A.	4,199,692	04/22/1980	Neale			
B.	5,536,947	07/16/1996	Klersy et al.			
C.						
D.						

U.S. PATENT APPLICATION PUBLICATIONS

E.	US 2004/0228159	11/18/2004	Kostylev et al.			
F.						
G.						
H.						

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES	NO
I.	EP 1 489 623	12/22/2004	Europe				
J.	WO 00/57498	09/28/2000	PCT				
K.	WO 2004/055828	07/01/2004	PCT				
L.	WO 2004/055899	07/01/2004	PCT				
M.	WO 2005/017904	02/24/2005	PCT				

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

N.	Yi-Chou Chen et al., <i>An Access-Transistor-Free (OT/1R) Non-Volatile Resistance Random Access Memory (RRAM) Using A Novel Threshold Switching, Self-Rectifying Chalcogenide Device</i> , Intl. Electron Devices Mtg. 2003, IEDM, Technical Digest, Washington, DC Dec. 8-10, 2003, New York, NY: IEEE, pgs. 905-908.
O.	Agostino Pirovano et al., <i>Low-Field Amorphous State Resistance And Threshold Voltage Drift In Chalcogenide Materials</i> , IEEE Transactions On Electron Devices, IEEE Inc., New York, NY, Vol. 51, No. 5, May 2004, pgs. 714-719.
P.	F. Pellizzer et al., <i>Novel μTrench Phase-Change Memory Cell For Embedded And Stand-Alone Non-Volatile Memory Applications</i> , VLSI Technology, 2004, Digest of Technical Papers 2004 Symposium, Honolulu, HI, June 15-17, 2004, Piscataway, NJ, IEEE, June 15, 2004, pgs. 18-19.
Q.	
R.	

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.